

Search Notes

Application No.

10/620,068

Examiner

John Hoffmann

Applicant(s)

CHANG ET AL.

Art Unit

1731

SEARCHED

Class	Subclass	Date	Examiner
T0	Pat	3-05	PH

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR